



P-Channel 30 V (D-S) MOSFET

MOSFET PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I _D (A) ^a	Q _g (Typ.)		
- 30	0.042 at V _{GS} = - 10 V	- 4.5	7.1 nC		
- 30	0.056 at V _{GS} = - 4.5 V	- 3.4	7.1 nC		

FEATURES

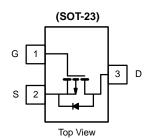
- DT-Trench Power MOSFET
- 100 % R_g Tested

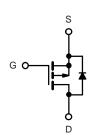
APPLICATIONS

- · Load Switch
- Notebook Adaptor Switch
- DC/DC Converter
- Power Management









P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T	$_{A}$ = 25 °C, unless oth	nerwise noted)			
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 30	V	
Gate-Source Voltage		V_{GS}	± 20		
	T _C = 25 °C		- 4.5		
Continuous Drain Current (T _{.1} = 150 °C)	$T_C = 70 ^{\circ}C$	I ₂ [- 3.5		
Sommodo Brain Sanon (1) = 100 S)	T _A = 25 °C	I _D	- 4.2 ^{b,c}	A	
	T _A = 70 °C		- 3.5 ^{b,c}	Α	
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 29		
Continuous Source-Drain Diode Current	T _C = 25 °C	la	- 4.5		
Continuous Source-Diain Diode Current	T _A = 25 °C	I _S	- 3.85 ^{b,c}		
	T _C = 25 °C		2.0		
Maximum Power Dissipation	T _C = 70 °C	PD	1.28	W	
Maximum Fower Dissipation	T _A = 25 °C	' b	1.43 ^{b, c}	VV	
	T _A = 70 °C		0.92 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	≤ 5 s	R _{thJA}	90	120	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	55	70	C/VV		

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 175 °C/W.



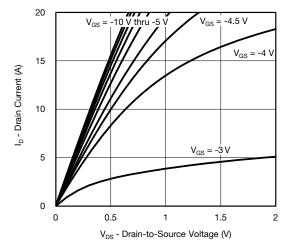
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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				l .		_
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			- 25		m\//0C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		3.9		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.6		- 1.3	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zoro Coto Voltago Proin Current	lana	$V_{DS} = -24 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = - 24 V, V _{GS} = 0 V, T _J = 55 °C			- 10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 4.5			Α
5	D	V _{GS} = - 10 V, I _D = - 3.8 A		0.042	0.058	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -3 \text{ A}$		0.056	0.084	Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 5 V, I _D = - 3.8 A		10		S
Dynamic ^b						
Input Capacitance	C _{iss}			715		
Output Capacitance	C _{oss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		95		pF
Reverse Transfer Capacitance	C _{rss}			70		ρr
Total Cata Chargo	0	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 4 A				
Total Gate Charge	Qg			7.1	10.4	20
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4 \text{ A}$		2.3		nC
Gate-Drain Charge	Q_{gd}			2.1		
Gate Resistance	R_g	f = 1 MHz	1.7	8.3	17	Ω
Turn-On Delay Time	t _{d(on)}			6	12	
Rise Time	t _r	V_{DD} = - 15 V, R_L = 5 Ω		6	12	200
Turn-Off Delay Time	t _{d(off)}	I_D = - 3 A, V_{GEN} = - 10 V, R_G = 1 Ω		19	29	ns
Fall Time	t _f			9	18	
Turn-On Delay Time	t _{d(on)}			10	20	
Rise Time	t _r	V_{DD} = - 15 V, R_L = 5 Ω		9	18	
Turn-Off Delay Time	t _{d(off)}	I_D = - 3 A, V_{GEN} = - 6 V, R_G = 1 Ω		18	27	ns
Fall Time	t _f			7	14	
Drain-Source Body Diode Characterist	ics					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 4.5	
Pulse Diode Forward Current ^a	I _{SM}				- 28	A
Body Diode Voltage	V_{SD}	I _S = - 3 A		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}			13	20	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 3 A, dl/dt = 100 A/µs, T _J = 25 °C		5	10	nC
Reverse Recovery Fall Time	t _a	i _F = -3 A, αί/αι = 100 Α/μδ, 1 _J = 25 °C		8		
Reverse Recovery Rise Time	t _b			6		ns

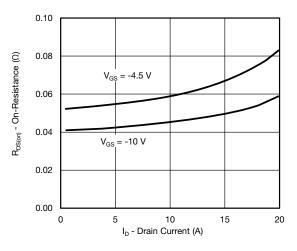
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Notes: a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

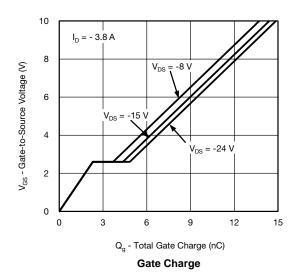


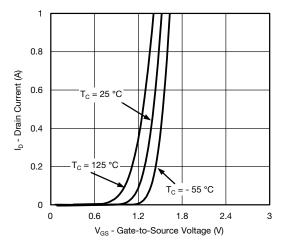


Output Characteristics

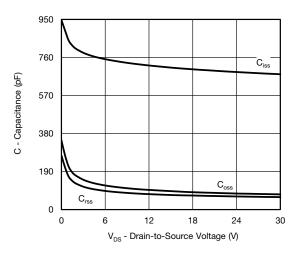


On-Resistance vs. Drain Current and Gate Voltage

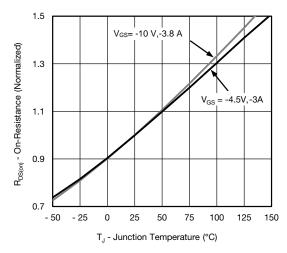




Transfer Characteristics

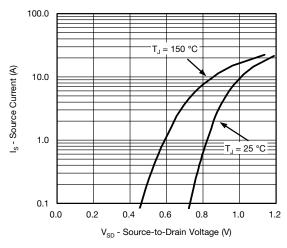


Capacitance

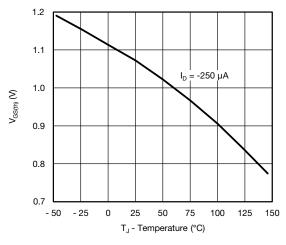


On-Resistance vs. Junction Temperature

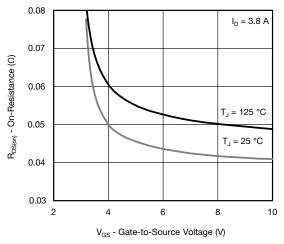




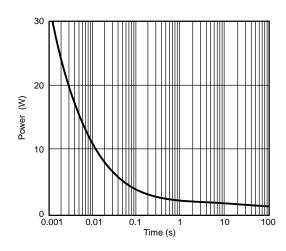
Source-Drain Diode Forward Voltage



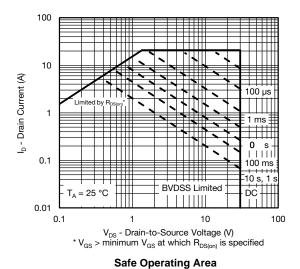
Threshold Voltage



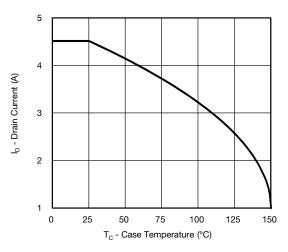
On-Resistance vs. Gate-to-Source Voltage



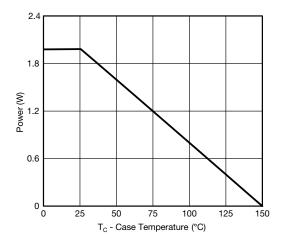
Single Pulse Power



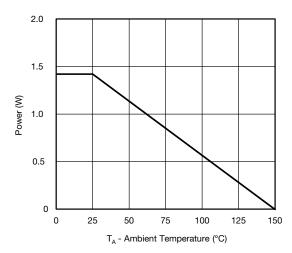




Current Derating*



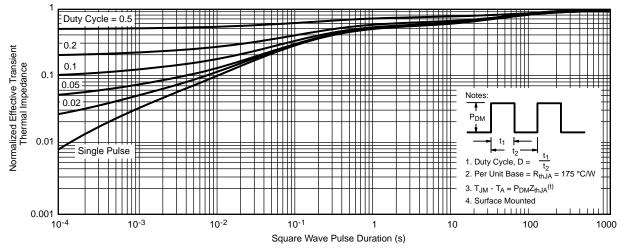




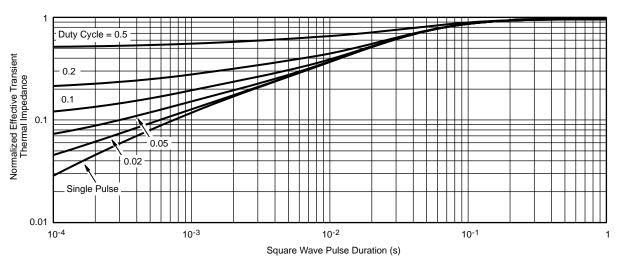
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





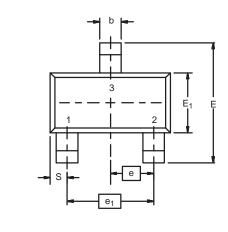
Normalized Thermal Transient Impedance, Junction-to-Ambient

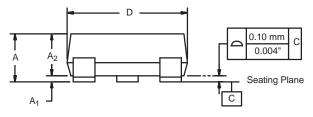


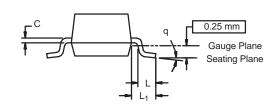
Normalized Thermal Transient Impedance, Junction-to-Foot



SOT-23 (TO-236): 3-LEAD





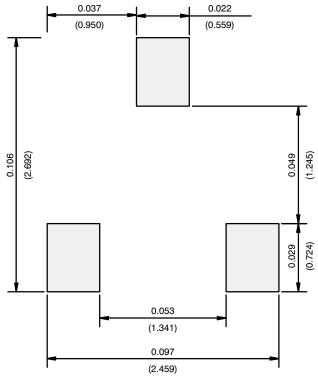


Dim	MILLIMETERS		INCHES	
	Min	Max	Min	Max
Α	0.89	1.12	0.035	0.044
A ₁	0.01	0.10	0.0004	0.004
A ₂	0.88	1.02	0.0346	0.040
b	0.35	0.50	0.014	0.020
С	0.085	0.18	0.003	0.007
D	2.80	3.04	0.110	0.120
E	2.10	2.64	0.083	0.104
E ₁	1.20	1.40	0.047	0.055
е	0.95 BSC		0.0374 Ref	
e ₁	1.90	1.90 BSC		8 Ref
L	0.40	0.60	0.016	0.024
L ₁	0.64 Ref		0.025	5 Ref
S	0.50 Ref		0.020) Ref
q	3°	8°	3°	8°

DWG: 5479



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)





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